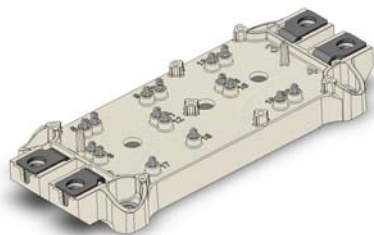


# SEMiX353GB176HDs



SEMiX<sup>®</sup> 3s

## Trench IGBT Modules

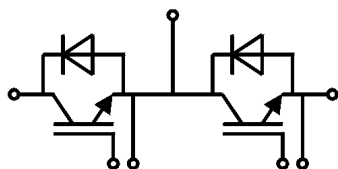
### SEMiX353GB176HDs

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- UL recognised file no. E63532

#### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders

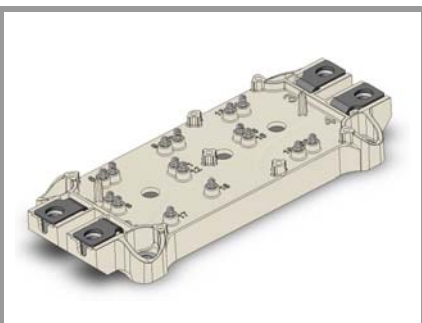


GB

Absolute Maximum Ratings				
Symbol	Conditions	Values	Unit	
<b>IGBT</b>				
$V_{CES}$		1700	V	
$I_C$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	353	A
		$T_c = 80\text{ °C}$	251	A
$I_{Cnom}$		225	A	
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	450	A	
$V_{GES}$		-20 ... 20	V	
$t_{psc}$	$V_{CC} = 1000\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1700\text{ V}$	$T_j = 125\text{ °C}$	10	$\mu\text{s}$
$T_j$		-55 ... 150	$^{\circ}\text{C}$	
<b>Inverse diode</b>				
$I_F$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	428	A
		$T_c = 80\text{ °C}$	289	A
$I_{Fnom}$		225	A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	450	A	
$I_{FSM}$	$t_p = 10\text{ ms, sin } 180^{\circ}, T_j = 25\text{ °C}$	1800	A	
$T_j$		-40 ... 150	$^{\circ}\text{C}$	
<b>Module</b>				
$I_{t(RMS)}$		600	A	
$T_{stg}$		-40 ... 125	$^{\circ}\text{C}$	
$V_{isol}$	AC sinus 50Hz, t = 1 min	4000	V	

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>IGBT</b>					
$V_{CE(sat)}$	$I_C = 225\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25\text{ °C}$	2	2.45	V
		$T_j = 125\text{ °C}$	2.45	2.9	V
$V_{CE0}$		$T_j = 25\text{ °C}$	1	1.2	V
		$T_j = 125\text{ °C}$	0.9	1.1	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$	4.4	5.6	$\text{m}\Omega$
		$T_j = 125\text{ °C}$	6.9	8.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 9\text{ mA}$	5.2	5.8	6.4	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ $V_{CE} = 1700\text{ V}$	$T_j = 25\text{ °C}$	0.1	0.3	$\text{mA}$
		$T_j = 125\text{ °C}$			$\text{mA}$
$C_{ies}$	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	19.9		nF
$C_{oes}$		$f = 1\text{ MHz}$	0.83		nF
$C_{res}$		$f = 1\text{ MHz}$	0.66		nF
$Q_G$	$V_{GE} = -8\text{ V...} + 15\text{ V}$		2100		nC
$R_{Gint}$	$T_j = 25\text{ °C}$		2.83		$\Omega$
$t_{d(on)}$	$V_{CC} = 1200\text{ V}$	$T_j = 125\text{ °C}$	250		ns
$t_r$	$I_C = 225\text{ A}$	$T_j = 125\text{ °C}$	75		ns
$E_{on}$	$R_{G\ on} = 5.6\ \Omega$	$T_j = 125\text{ °C}$	155		mJ
$t_{d(off)}$	$R_{G\ off} = 5.6\ \Omega$	$T_j = 125\text{ °C}$	930		ns
$t_f$		$T_j = 125\text{ °C}$	180		ns
$E_{off}$		$T_j = 125\text{ °C}$	85		mJ
$R_{th(j-c)}$	per IGBT			0.086	K/W

# SEMiX353GB176HDs



SEMiX® 3s

## Trench IGBT Modules

### SEMiX353GB176HDs

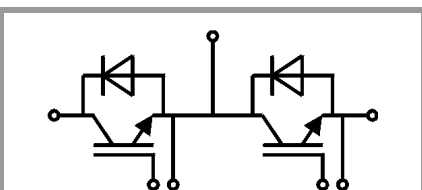
#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- UL recognised file no. E63532

#### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Inverse diode</b>						
$V_F = V_{EC}$	$I_F = 225\text{ A}$ $V_{GE} = 0\text{ V}$ chip	$T_j = 25\text{ °C}$		1.6	1.75	V
		$T_j = 125\text{ °C}$		1.5	1.7	V
$V_{F0}$		$T_j = 25\text{ °C}$	0.9	1.1	1.3	V
		$T_j = 125\text{ °C}$	0.7	0.9	1.1	V
$r_F$		$T_j = 25\text{ °C}$	2.0	2.0	2.0	mΩ
		$T_j = 125\text{ °C}$	2.7	2.7	2.7	mΩ
$I_{RRM}$	$I_F = 225\text{ A}$	$T_j = 125\text{ °C}$		280		A
$Q_{rr}$	$di/dt_{off} = 4000\text{ A}/\mu\text{s}$	$T_j = 125\text{ °C}$		83		μC
$E_{rr}$	$V_{GE} = -15\text{ V}$ $V_{CC} = 1200\text{ V}$	$T_j = 125\text{ °C}$		45		mJ
$R_{th(j-c)}$	per diode				0.13	K/W
<b>Module</b>						
$L_{CE}$				20		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_C = 25\text{ °C}$		0.7		mΩ
		$T_C = 125\text{ °C}$		1		mΩ
$R_{th(c-s)}$	per module			0.04		K/W
$M_s$	to heat sink (M5)		3		5	Nm
$M_t$		to terminals (M6)	2.5		5	Nm
						Nm
$w$					300	g
<b>Temperatur Sensor</b>						
$R_{100}$	$T_c = 100\text{ °C}$ ( $R_{25} = 5\text{ k}\Omega$ )			$493 \pm 5\%$		Ω
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$ ; $T[\text{K}]$ ;			$3550 \pm 2\%$		K



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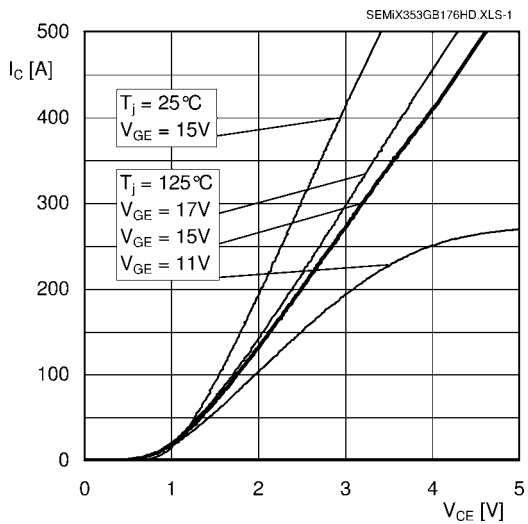


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+EE'}$

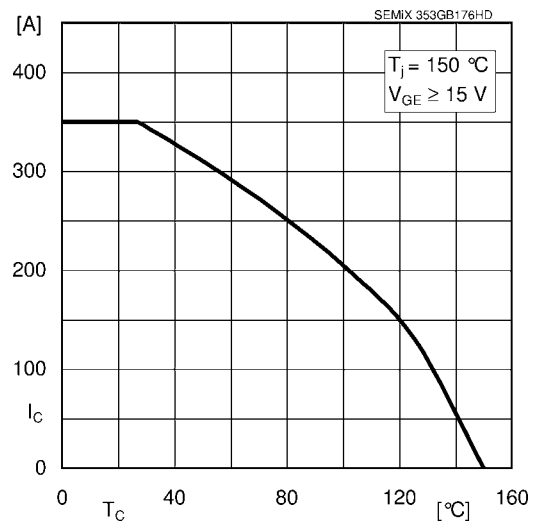


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

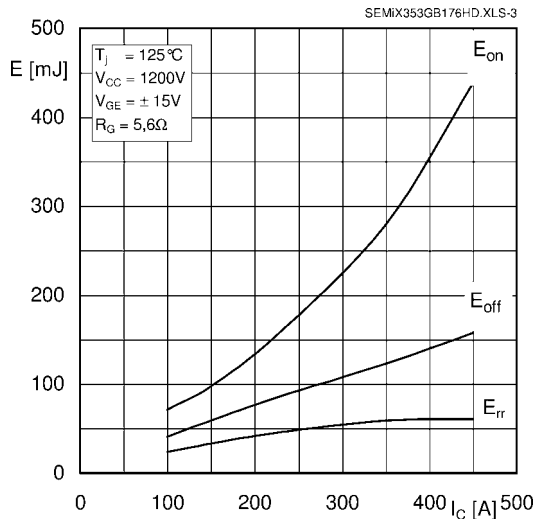


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

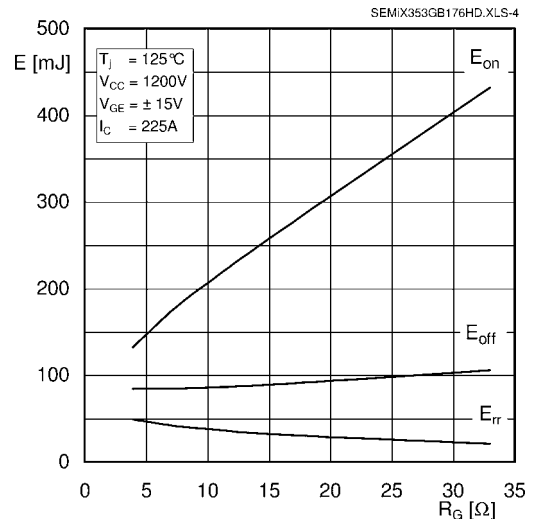


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

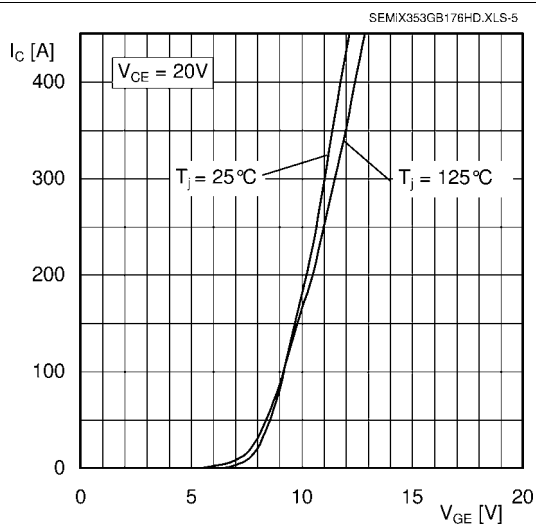


Fig. 5: Typ. transfer characteristic

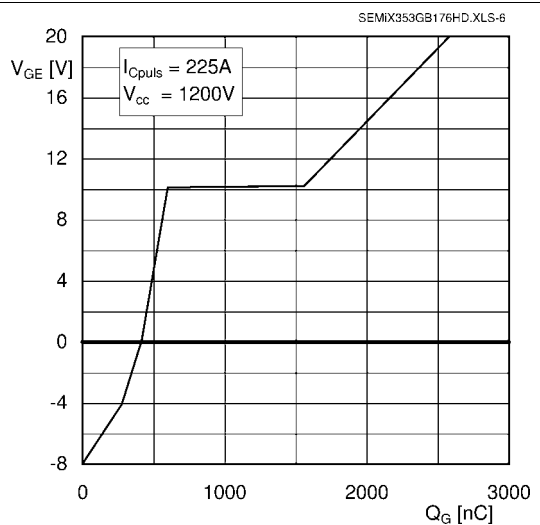


Fig. 6: Typ. gate charge characteristic

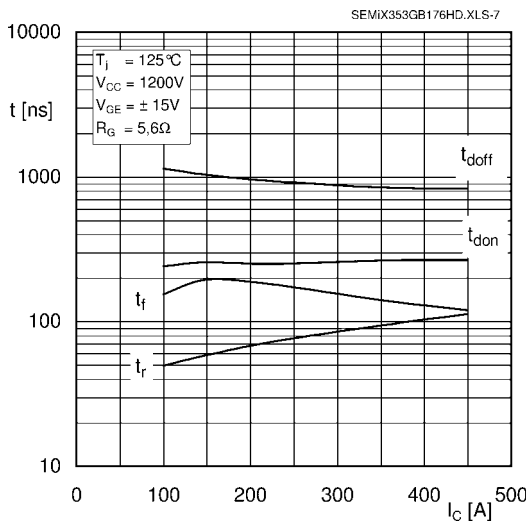


Fig. 7: Typ. switching times vs.  $I_C$

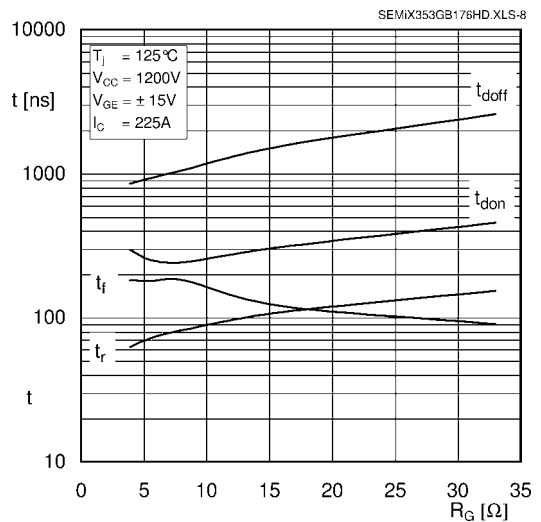


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

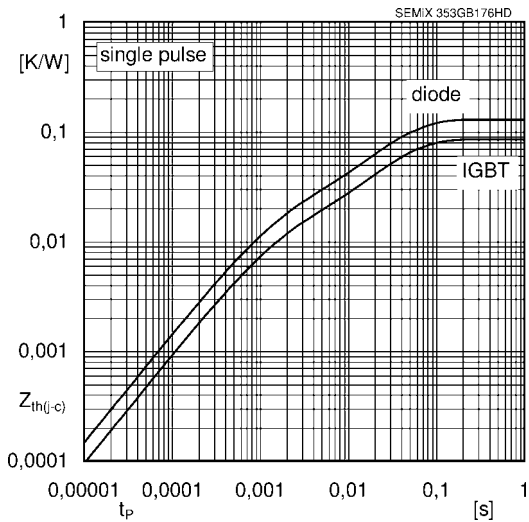


Fig. 9: Typ. transient thermal impedance

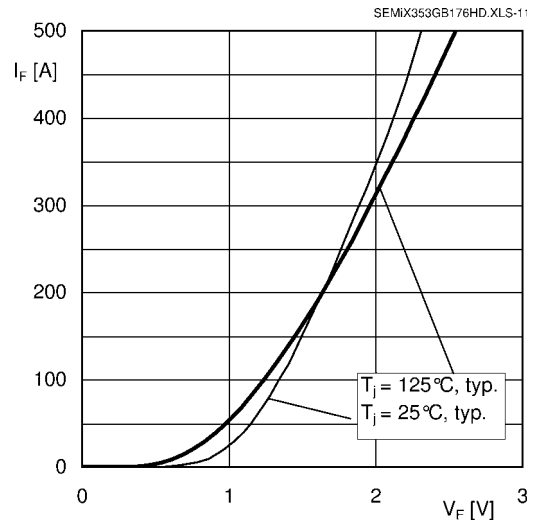


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC+EE}$

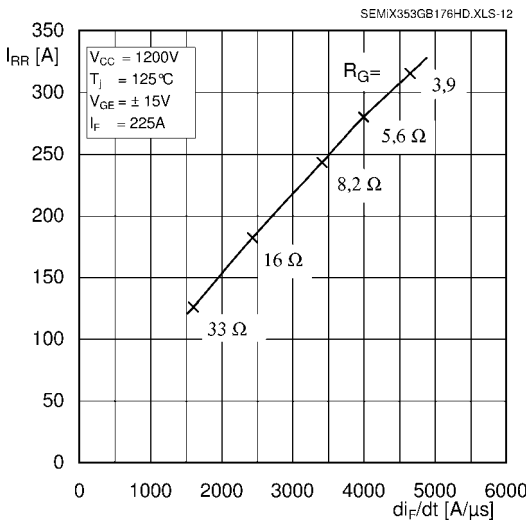


Fig. 11: Typ. CAL diode peak reverse recovery current

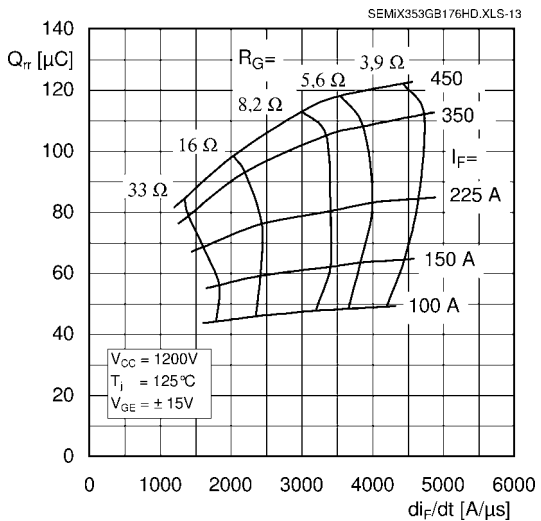


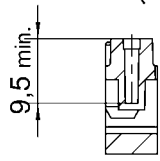
Fig. 12: Typ. CAL diode recovery charge

# SEMiX353GB176HDs

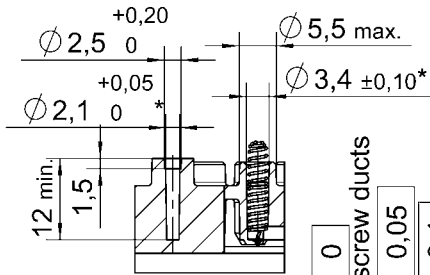
Case: SEMiX 3s

general tolerance ISO 2768-mK

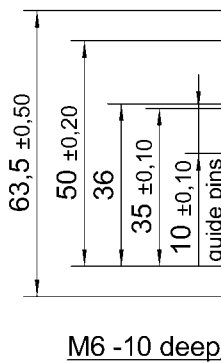
screw duct  
(1x centre) :  
H-H (1:1)



screw duct (6x)  
spring duct (16x) :  
A-A (1:1)

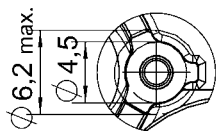


marking of terminals

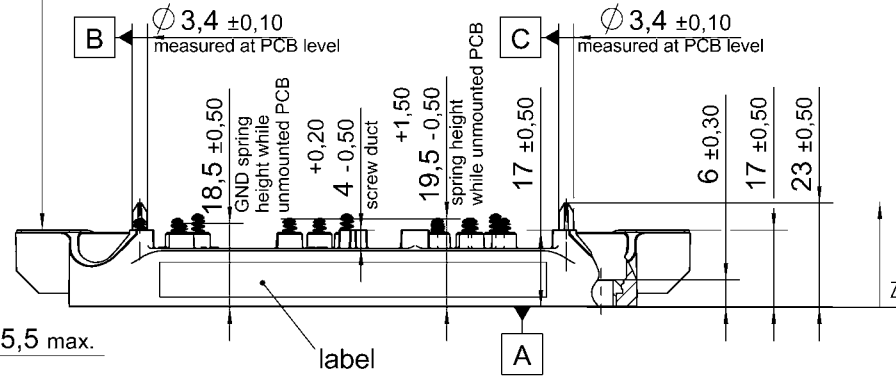


M6 -10 deep

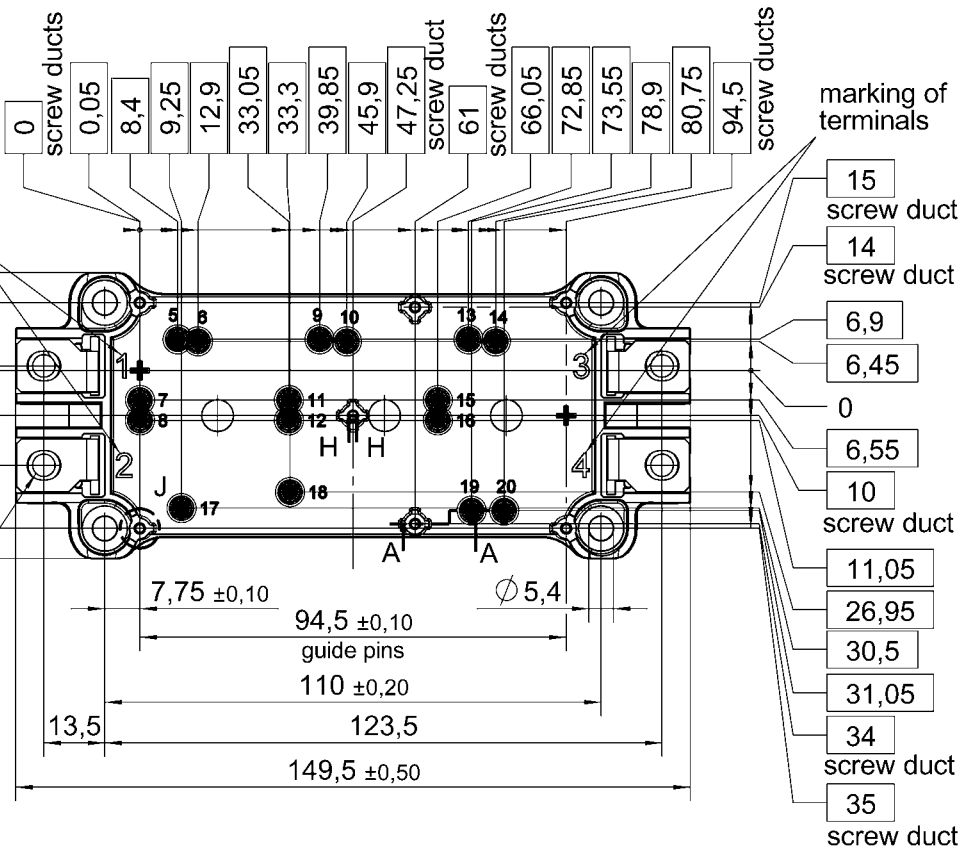
screw duct  
top view (7x) :  
J (2:1)



	0,3	connector 1-2 / 3-4
	0,2	each connector A



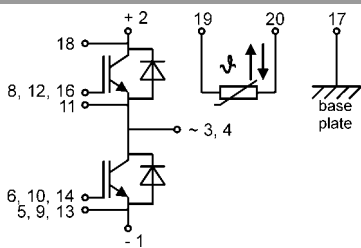
All measures in Z-direction  
valid as mounted to heat sink



\*screw ducts / spring ducts with  $\phi \pm 0,2$  A B C

Rules for the contact PCB:  
- holes guidepins =  $\phi 4 \pm 0,1$  / position tolerance  $\pm 0,1$   
- spring landing pad =  $\phi 3,5 \pm 0,2$  / position tolerance  $\pm 0,2$

SEMiX 3s



spring configuration

# SEMiX353GB176HDs

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